

IRFI7536GPBF-VB Datasheet

N-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY

| V_{DS} (V) | $R_{DS(on)}$ (Ω) | I_D (A) ^a |
|--------------|---------------------------|------------------------|
| 60 | 0.003 at $V_{GS} = 10$ V | 210 |
| | 0.005 at $V_{GS} = 4.5$ V | 185 |

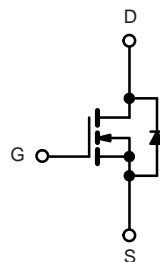
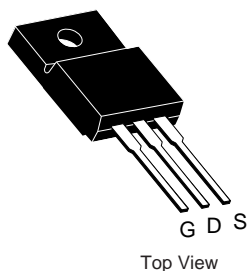
FEATURES

- 175 °C Junction Temperature
- Trench Power MOSFET
- Material categorization:



RoHS
COMPLIANT

TO-220 FULLPAK



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS ($T_C = 25$ °C, unless otherwise noted)

| Parameter | | Symbol | Limit | Unit |
|---|----------------|----------------|--------------------------------------|------|
| Gate-Source Voltage | | V_{GS} | ± 20 | V |
| Continuous Drain Current ($T_J = 175$ °C) ^b | $T_C = 25$ °C | I_D | 210 | A |
| | $T_C = 100$ °C | | 185 ^a | |
| Pulsed Drain Current | | I_{DM} | 200 | |
| Continuous Source Current (Diode Conduction) | | I_S | 180 ^a | |
| Avalanche Current | | I_{AS} | 70 | |
| Single Avalanche Energy (Duty Cycle ≤ 1 %) | $L = 0.1$ mH | E_{AS} | 125 | mJ |
| Maximum Power Dissipation | $T_C = 25$ °C | P_D | 136 | W |
| | $T_A = 25$ °C | | 3 ^b , 8.3 ^{b, c} | |
| Operating Junction and Storage Temperature Range | | T_J, T_{stg} | - 55 to 175 | °C |

THERMAL RESISTANCE RATINGS

| Parameter | | Symbol | Typical | Maximum | Unit |
|--|-----------------|------------|---------|---------|------|
| Maximum Junction-to-Ambient ^a | $t \leq 10$ sec | R_{thJA} | 15 | 18 | °C/W |
| | Steady State | | 40 | 50 | |
| Maximum Junction-to-Case | | R_{thJC} | 0.85 | 1.1 | |

Notes:

a. Package limited.

b. Surface mounted on 1" x 1" FR4 board.

c. $t \leq 10$ s.

SPECIFICATIONS ($T_J = 25\text{ }^{\circ}\text{C}$, unless otherwise noted)

| Parameter | Symbol | Test Conditions | Min. | Typ. ^a | Max. | Unit |
|---|---------------------|--|------|-------------------|-------|------|
| Static | | | | | | |
| Drain-Source Breakdown Voltage | V _{DS} | V _{GS} = 0 V, I _D = 250 μA | 60 | | | V |
| Gate Threshold Voltage | V _{GS(th)} | V _{DS} = V _{GS} , I _D = 250 μA | 1 | 2 | 3 | |
| Gate-Body Leakage | I _{GSS} | V _{DS} = 0 V, V _{GS} = ± 20 V | | | ± 100 | nA |
| Zero Gate Voltage Drain Current | I _{DSS} | V _{DS} = 60 V, V _{GS} = 0 V | | | 1 | μA |
| | | V _{DS} = 60 V, V _{GS} = 0 V, T _J = 125 °C | | | 50 | |
| | | V _{DS} = 60 V, V _{GS} = 0 V, T _J = 175 °C | | | 250 | |
| On-State Drain Current ^b | I _{D(on)} | V _{DS} = 5 V, V _{GS} = 10 V | 60 | | | A |
| Drain-Source On-State Resistance ^b | R _{DS(on)} | V _{GS} = 10 V, I _D = 20 A | | 0.003 | | Ω |
| | | V _{GS} = 10 V, I _D = 20 A, T _J = 125 °C | | 0.008 | | |
| | | V _{GS} = 10 V, I _D = 20 A, T _J = 175 °C | | 0.010 | | |
| | | V _{GS} = 4.5 V, I _D = 15 A | | 0.005 | | |
| Forward Transconductance ^b | g _{fs} | V _{DS} = 15 V, I _D = 20 A | | 60 | | S |
| Dynamic | | | | | | |
| Input Capacitance | C _{iss} | V _{GS} = 0 V, V _{DS} = 25 V, f = 1 MHz | | 2650 | | pF |
| Output Capacitance | C _{oss} | | | 470 | | |
| Reverse Transfer Capacitance | C _{rss} | | | 225 | | |
| Total Gate Charge ^c | Q _g | V _{DS} = 30 V, V _{GS} = 10 V, I _D = 50 A | | 47 | 70 | nC |
| Gate-Source Charge ^c | Q _{gs} | | | 10 | | |
| Gate-Drain Charge ^c | Q _{gd} | | | 12 | | |
| Turn-On Delay Time ^c | t _{d(on)} | V _{DD} = 30 V, R _L = 0.6 Ω I _D ≅ 50 A, V _{GEN} = 10 V, R _g = 2.5 Ω | | 10 | 20 | ns |
| Rise Time ^c | t _r | | | 15 | 25 | |
| Turn-Off Delay Time ^c | t _{d(off)} | | | 35 | 50 | |
| Fall Time ^c | t _f | | | 20 | 30 | |
| Source-Drain Diode Ratings and Characteristics (T _C = 25 °C) | | | | | | |
| Pulsed Current | I _{SM} | | | | 60 | A |
| Diode Forward Voltage | V _{SD} | I _F = 20 A, V _{GS} = 0 V | | 1 | 1.5 | V |
| Reverse Recovery Time | t _{rr} | I _F = 20 A, di/dt = 100 A/μs | | 45 | 100 | ns |

Notes:

- a. For design aid only; not subject to production testing.
 b. Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$.
 c. Independent of operating temperature.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

TYPICAL CHARACTERISTICS (25 °C unless noted)



Output Characteristics



Transfer Characteristics



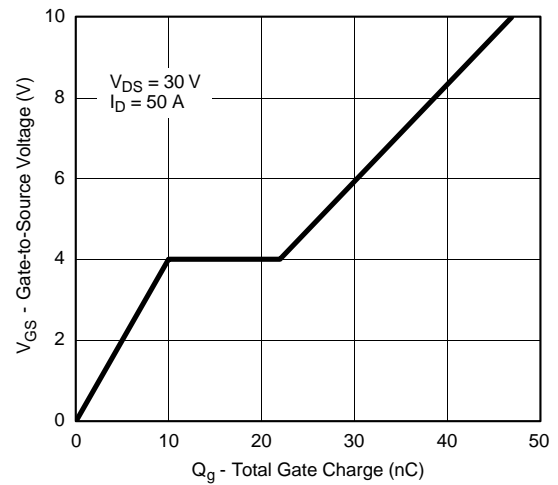
Transconductance



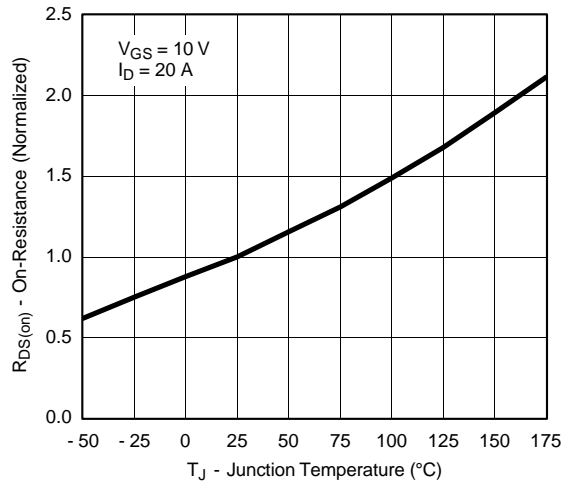
On-Resistance vs. Drain Current



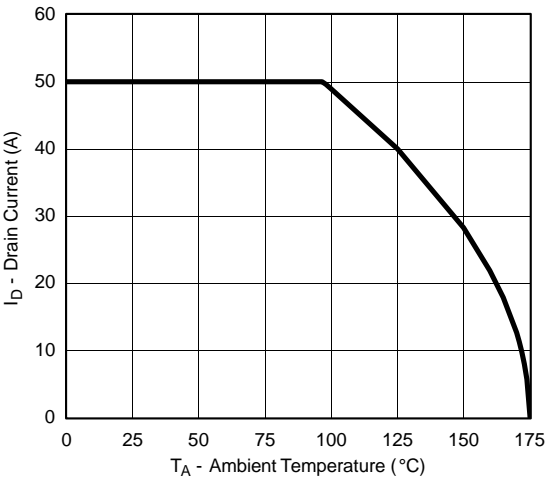
Capacitance



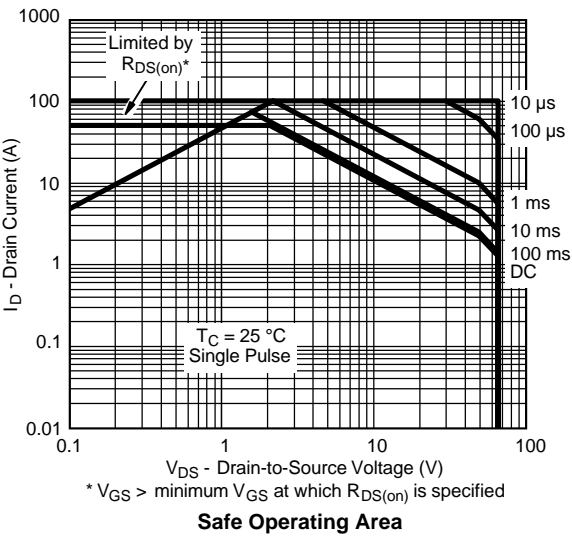
Gate Charge

TYPICAL CHARACTERISTICS (25 °C unless noted)**On-Resistance vs. Junction Temperature****Source-Drain Diode Forward Voltage**

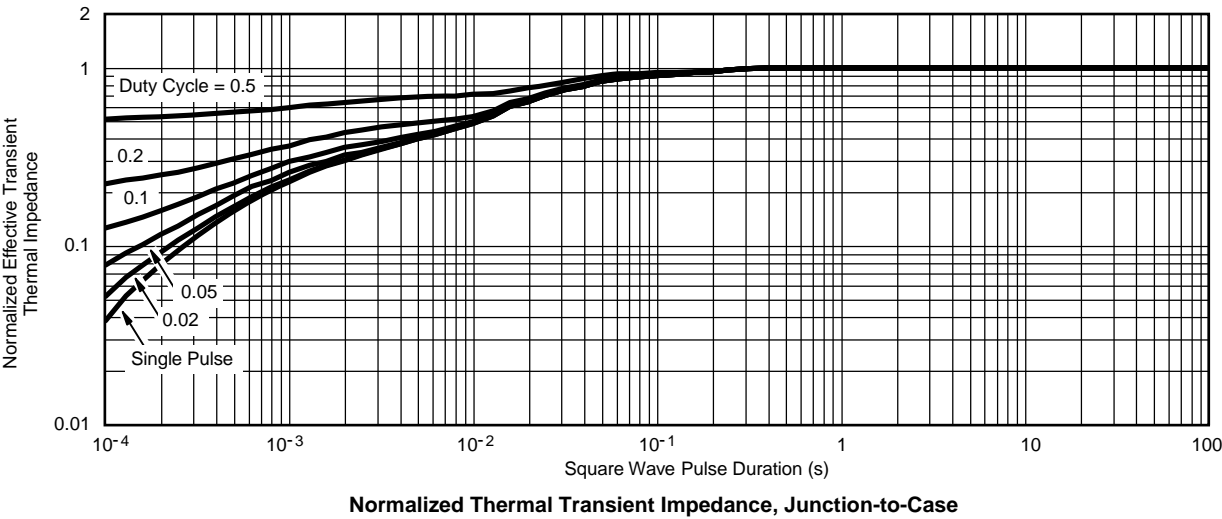
THERMAL RATINGS



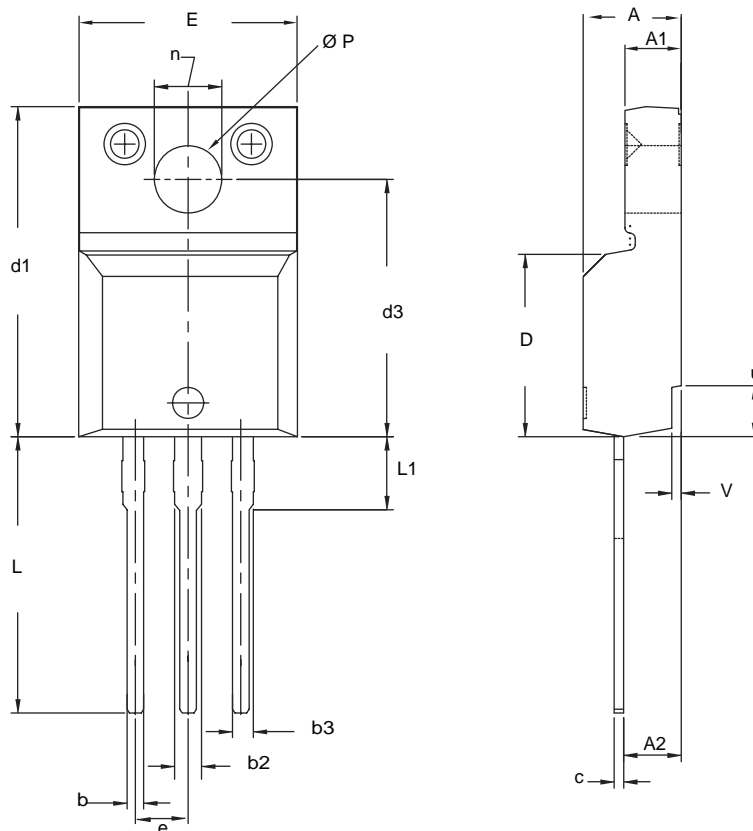
Maximum Drain Current vs. Ambient Temperature



Safe Operating Area



Normalized Thermal Transient Impedance, Junction-to-Case

TO-220 FULLPAK (HIGH VOLTAGE)

| DIM. | MILLIMETERS | | INCHES | |
|------|-------------|--------|-----------|-------|
| | MIN. | MAX. | MIN. | MAX. |
| A | 4.570 | 4.830 | 0.180 | 0.190 |
| A1 | 2.570 | 2.830 | 0.101 | 0.111 |
| A2 | 2.510 | 2.850 | 0.099 | 0.112 |
| b | 0.622 | 0.890 | 0.024 | 0.035 |
| b2 | 1.229 | 1.400 | 0.048 | 0.055 |
| b3 | 1.229 | 1.400 | 0.048 | 0.055 |
| c | 0.440 | 0.629 | 0.017 | 0.025 |
| D | 8.650 | 9.800 | 0.341 | 0.386 |
| d1 | 15.88 | 16.120 | 0.622 | 0.635 |
| d3 | 12.300 | 12.920 | 0.484 | 0.509 |
| E | 10.360 | 10.630 | 0.408 | 0.419 |
| e | 2.54 BSC | | 0.100 BSC | |
| L | 13.200 | 13.730 | 0.520 | 0.541 |
| L1 | 3.100 | 3.500 | 0.122 | 0.138 |
| n | 6.050 | 6.150 | 0.238 | 0.242 |
| Ø P | 3.050 | 3.450 | 0.120 | 0.136 |
| u | 2.400 | 2.500 | 0.094 | 0.098 |
| v | 0.400 | 0.500 | 0.016 | 0.020 |

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 DWG: 5972

Notes

1. To be used only for process drawing.
2. These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads.
3. All critical dimensions should C meet $C_{pk} > 1.33$.
4. All dimensions include burrs and plating thickness.
5. No chipping or package damage.

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